

Notice of References Cited	Application/Control No. 10/804,100	Applicant(s)/Patent Under Reexamination OOTERA, YASUAKI	
	Examiner Anna L. Verderame	Art Unit 1756	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0043328	04-2002	Yamasaki et al.	156/240
*	B	US-2004/0151869	08-2004	Tokuda et al.	428/065.2
*	C	US-2003/0137924	07-2003	Aratani et al.	369/288
*	D	US-6,017,603	01-2000	Tokuda et al.	428/64.1
*	E	US-6,312,547	11-2001	Fujimori et al.	156/242
*	F	US-6,596,104	07-2003	Tomiyama, Morio	156/64
*	G	US-6,512,735	01-2003	Takeda et al.	369/275.4
*	H	US-6,352,656	03-2002	Kimura et al.	264/2.5
*	I	US-6,532,206	03-2003	Muramatsu et al.	369/275.3
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 10-293945	11-1998	Japan	Yamada et al.	
	O	WO 02/054396	11-2002	Japan	Aratani et al.	
	P	WO 02/095744	11-2002	Japan	Tokuda et al.	I
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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